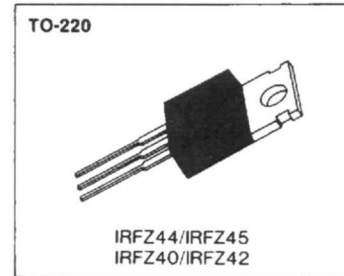


**IRFZ44/45  
IRFZ40/42**

**N-CHANNEL  
POWER MOSFETS**

**FEATURES**

- Lower  $R_{DS(on)}$
- Improved inductive ruggedness
- Fast switching times
- Rugged polysilicon gate cell structure
- Lower input capacitance
- Extended safe operating area
- Improved high temperature reliability



**PRODUCT SUMMARY**

Part Number	$V_{DS}$	$R_{DS(on)}$	$I_D$
IRFZ44	60V	0.028 $\Omega$	35A
IRFZ45	60V	0.035 $\Omega$	35A
IRFZ40	50V	0.028 $\Omega$	35A
IRFZ42	50V	0.035 $\Omega$	35A

\* Current limited by wire & pin diameter

**MAXIMUM RATINGS**

Characteristic	Symbol	IRFZ44	IRFZ45	IRFZ40	IRFZ42	Unit
Drain-Source Voltage (1)	$V_{DSS}$	60		50		Vdc
Drain-Gate Voltage ( $R_{GS}=1\text{ OM}\Omega$ )(1)	$V_{DGR}$	60		50		Vdc
Gate-Source Voltage	$V_{GS}$	$\pm 20$				Vdc
Continuous Drain Current $T_C=25^\circ\text{C}$	$I_D$	35	35	35	35	Adc
Continuous Drain Current $T_C=100^\circ\text{C}$	$I_D$	35	33	35	33	Adc
Drain Current—Pulsed (3)	$I_{DM}$	210	190	210	190	Adc
Gate Current—Pulsed	$I_{GM}$	$\pm 1.5$				Adc
Single Pulsed Avalanche Energy (4)	$E_{AS}$	53				mJ
Avalanche Current	$I_{AS}$	35				A
Total Power Dissipation at $T_C=25^\circ\text{C}$ Derate above $25^\circ\text{C}$	$P_D$	150		1.2		Watts W/ $^\circ\text{C}$
Operating and Storage Junction Temperature Range	$T_J, T_{stg}$	-55 to 175 $^\circ$				$^\circ\text{C}$
Maximum Lead Temp. for Soldering Purposes, 1/8" from case for 5 seconds	$T_L$	300				$^\circ\text{C}$

- Notes: (1)  $T_J=25^\circ\text{C}$  to  $175^\circ\text{C}$   
 (2) Pulse test. Pulse width  $\leq 300\mu\text{s}$ , Duty Cycle  $\leq 2\%$   
 (3) Repetitive rating: Pulse with limited by max junction temperature  
 (4)  $L=50\mu\text{H}$ ,  $V_{dd}=25\text{V}$ ,  $R_G=25\Omega$ , Starting  $T_J=25^\circ\text{C}$



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# IRFZ44/45 IRFZ40/42

# N-CHANNEL POWER MOSFETS

## ELECTRICAL CHARACTERISTICS (T<sub>C</sub>=25°C unless otherwise specified)

Symbol	Characteristic	Min	Typ	Max	Units	Test Conditions
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	60	—	—	V	V <sub>GS</sub> =0V, I <sub>D</sub> =250μA
	IRFZ44/45	50	—	—		
V <sub>GS(th)</sub>	Gate Threshold Voltage	2.0	—	4.0	V	V <sub>DS</sub> =V <sub>GS</sub> , I <sub>D</sub> =250μA
I <sub>GSS</sub>	Gate-Source Leakage Forward	—	—	100	nA	V <sub>GS</sub> =20V
I <sub>GSS</sub>	Gate-Source Leakage Reverse	—	—	-100	nA	V <sub>GS</sub> =-20V
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	—	—	250	μA	V <sub>DS</sub> =Max. Rating, V <sub>GS</sub> =0V V <sub>DS</sub> =0.8Max. Rating, V <sub>GS</sub> =0V, T <sub>C</sub> =150°C
		—	—	1000	μA	
I <sub>D(on)</sub>	On-State Drain-Source Current (2)	35	—	—	A	V <sub>DS</sub> ≥1.2V, V <sub>GS</sub> =10V
R <sub>DS(on)</sub>	Static Drain-Source	—	—	0.028	Ω	V <sub>GS</sub> =10V, I <sub>D</sub> =33A
	On-State Resistance	—	—	0.035		
g <sub>fs</sub>	Forward Transconductance (2)	15	—	—	U	V <sub>DS</sub> ≥50V, I <sub>D</sub> =33A
C <sub>iss</sub>	Input Capacitance	—	2450	—	pF	V <sub>GS</sub> =0V
C <sub>oss</sub>	Output Capacitance	—	740	—	pF	V <sub>DS</sub> =25V
C <sub>rss</sub>	Reverse Transfer Capacitance	—	360	—	pF	f=1.0MHz
t <sub>d(on)</sub>	Turn-On Delay Time	—	—	32	ns	V <sub>DD</sub> =0.5 BV <sub>DSS</sub> , I <sub>D</sub> =52A, Z <sub>O</sub> =9.1Ω (MOSFET switching times are essentially independent of operating temperature)
t <sub>r</sub>	Rise Time	—	—	210	ns	
t <sub>d(off)</sub>	Turn-Off Delay Time	—	—	75	ns	
t <sub>f</sub>	Fall Time	—	—	130	ns	
Q <sub>g</sub>	Total Gate Charge (Gate-Source Pulse Gate-Drain)	—	—	100	nC	V <sub>GS</sub> =10V, I <sub>D</sub> =52A, V <sub>DS</sub> =0.8Max. Rating (Gate charge is essentially independent of operating temperature)
Q <sub>gs</sub>	Gate-Source Charge	—	—	21	nC	
Q <sub>gd</sub>	Gate-Drain ("Miller") Charge	—	—	58	nC	

## THERMAL RESISTANCE

R <sub>thJC</sub>	Junction-to-Case	MAX	1.0	K/W	
R <sub>thCS</sub>	Case-to-Sink	TYP	0.5	K/W	Mounting surface flat smooth, and greased
R <sub>thJA</sub>	Junction-to-Ambient	MAX	80	K/W	Free Air Operation

Notes: (1) T<sub>J</sub>=25°C to 175°C

(2) Pulse test Pulse width≤300μs, Duty Cycle≤2%

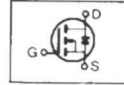
(3) Repetitive rating Pulse width limited by max junction temperature

**IRFZ44/45  
IRFZ40/42**

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**SOURCE-DRAIN DIODE RATINGS AND CHARACTERISTICS**

Symbol	Characteristic	IRFZ44/40	IRFZ45/42	Min	Typ	Max	Units	Test Conditions
$I_S$	Continuous Source Current (Body Diode)	IRFZ44/40	IRFZ45/42	—	—	35	A	Modified MOSFET integral reverse P-N junction rectifier
$I_{SM}$	Pulse-Source Current (3)	IRFZ44/40	IRFZ45/42	—	—	210	A	
$V_{SD}$	Diode Forward Voltage All			—	—	2.5	V	$T_C = 25^\circ\text{C}$ , $I_S = 35\text{A}$ , $V_{GS} = 0\text{V}$
$t_{rr}$	Reverse Recovery Time			—	—	250	ns	$T_J = 25^\circ\text{C}$ , $I_F = 35\text{A}$ , $dI_F/dt = 100\text{A}/\mu\text{S}$



- Notes:** (1)  $T_J = 25^\circ\text{C}$  to  $175^\circ\text{C}$   
 (2) Pulse test Pulse width  $\leq 300\mu\text{s}$ , Duty Cycle  $\leq 2\%$   
 (3) Repetitive rating Pulse with limited by max junction temperature

